

Search Notes

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Junghwa M. Im

Applicant(s)/Patent under
Reexamination

GAYNES ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAAT (uspat, uspub, jpo, epo, der, ibm)	11/7/2005	JMI
text search (see search history printout)	11/17/2005	jmi